


<b>Search Notes</b>  	<b>Application/Control No.</b>  10671671	<b>Applicant(s)/Patent Under Reexamination</b>  KNEBEL ET AL.
	<b>Examiner</b>  Keefer, Michael E	<b>Art Unit</b>  2109

SEARCHED			
Class	Subclass	Date	Examiner
709	231	1/16/2007	MEK
370	907	1/16/2007	MEK
709	221	1/16/2007	MEK
714	4	1/29/2007	MEK
370	225	1/30/2007	MEK
379	221.01-221.04	1/30/2007	MEK
370	217-218	2/2/2007	MEK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search	2/2/2007	MEK
Consulted Primary Examiner Patrice Winder	1/18/2007	MEK
Consulted SPE Andrew Caldwell	1/27/2007	MEK
STIC Database Search	2/2/2007	MEK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner